

RoHS

COMPLIANT

HALOGEN FREE

VSO007N04MS-VB Datasheet

N-Channel 40-V (D-S) MOSFET

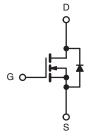
PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)(Typ.)	I _D (A) ^a	Q _g (Typ.)		
40	0.002 at V _{GS} = 10 V	36	32.5 nC		
	0.003 at V _{GS} = 4.5 V	33	32.5 110		

FEATURES

- Halogen-free According to IEC 61249-2-21 ٠ Definition
- Trench Power MOSFET
- 100 % R_g and UIS Tested
 Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- POL
- Synchronous Rectification



N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	IGS T _A = 25 °C,	unless othe	erwise noted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	40	V	
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C		36		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I _D	26		
Continuous Drain Current (1j = 150°C)	T _A = 25 °C	טי	24 ^{b, c}		
	T _A = 70 °C		19 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	70	A	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	7.0		
	T _A = 25 °C	'S	3.1 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	40		
Avalanche Energy		E _{AS}	80	mJ	
	T _C = 25 °C		7.8		
Maximum Power Dissipation	T _C = 70 °C	P _D	5.0	w	
	T _A = 25 °C	· D	3.5 ^{b, c}		
	T _A = 70 °C		2.2 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 150	°C	

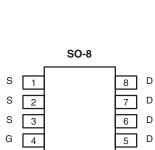
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	29	35	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	13	16		

Notes: a. Based on T_C = 25 °C.

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under Steady State conditions is 80 °C/W.



Top View

SPECIFICATIONS T _J = 25 °C,	unless other	wise noted					
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					•		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = 250 \mu A$	40			V	
V _{DS} Temperature Coefficient				45			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	- I _D = 250 μΑ		- 5.6		- mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	1.0		2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
	I _{DSS} –	V _{DS} = 40 V, V _{GS} = 0 V			1	μA	
Zero Gate Voltage Drain Current		$V_{DS} = 40 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 ^{\circ}\text{C}$			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	30			А	
	6	V _{GS} = 10 V, I _D = 15 A		0.002		Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 10 A		0.003			
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 15 A		75		S	
Dynamic ^b							
Input Capacitance	C _{iss}			4230			
Output Capacitance	C _{oss}	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz		570		pF	
Reverse Transfer Capacitance	C _{rss}	1		220			
Takal Qata Ohama	Q _g	$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$		70	105	nC	
Total Gate Charge		V _{DS} = 20 V, V _{GS} = 4.5 V, I _D = 20 A		32.5	49		
Gate-Source Charge	Q _{gs}			9.7			
Gate-Drain Charge	Q _{gd}			8.6			
Gate Resistance	Rg	f = 1 MHz	0.3	1.25	2.5	Ω	
Turn-On Delay Time	t _{d(on)}			25	50		
Rise Time				70	120	1	
Turn-Off Delay Time	t _{d(off)}	${ m I}_{ m D}\cong$ 10 A, ${ m V}_{ m GEN}$ = 4.5 V, ${ m R}_{ m g}$ = 1 Ω		51	90		
Fall Time	t _f			35	60		
Turn-On Delay Time t _{d(on)}				10	20	ns	
Rise Time t _r		V_{DD} = 20 V, R_L = 2 Ω		9	18		
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ 10 A, V_GEN = 10 V, R_g = 1 Ω		35	60		
Fall Time	t _f			7	14		
Drain-Source Body Diode Characteristi	cs			•	•		
Continuous Source-Drain Diode Current	ا _S	T _C = 25 °C			7.0	A	
Pulse Diode Forward Current ^a	I _{SM}				70		
Body Diode Voltage	V _{SD}	I _S = 3 A		0.71	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			33	65	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	=		29	56	nC	
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^\circ\text{C}$		17			
Beverse Becovery Bise Time t		1 – – – – – – – – – – – – – – – – – – –	-	16	İ	ns	

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %

Reverse Recovery Rise Time

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

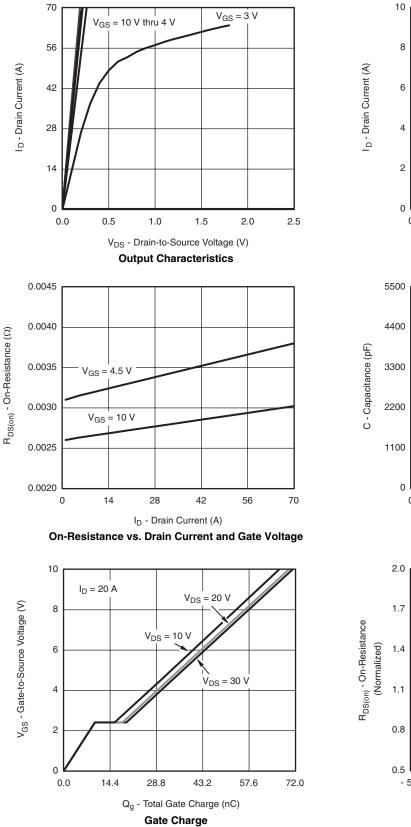
t_b

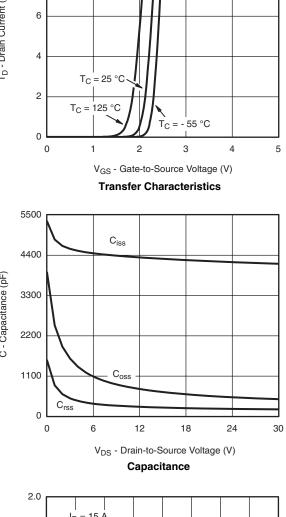
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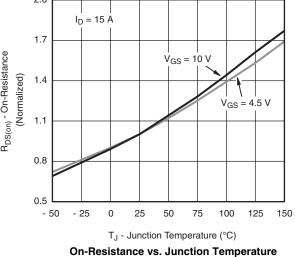
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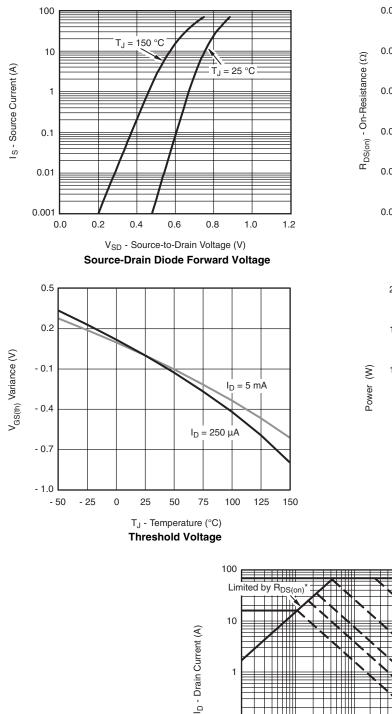


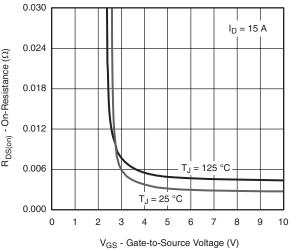




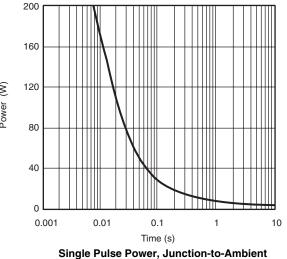
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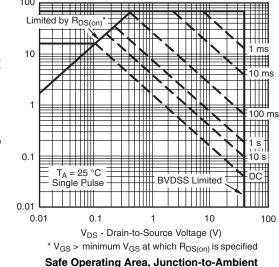




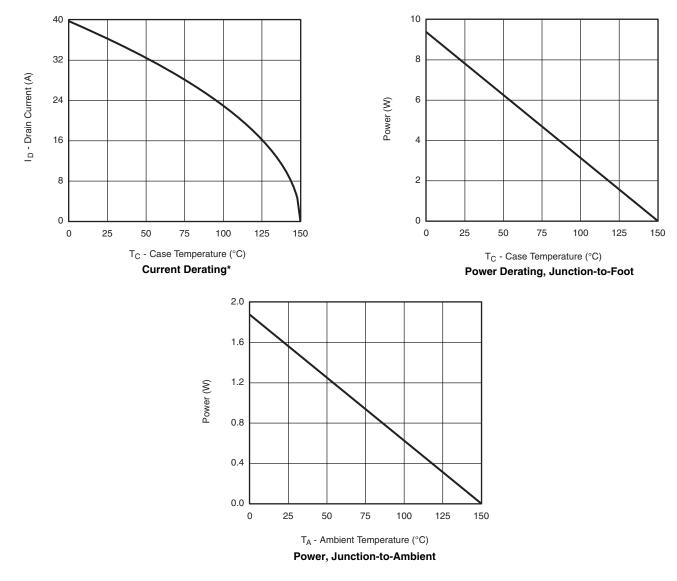


On-Resistance vs. Gate-to-Source Voltage



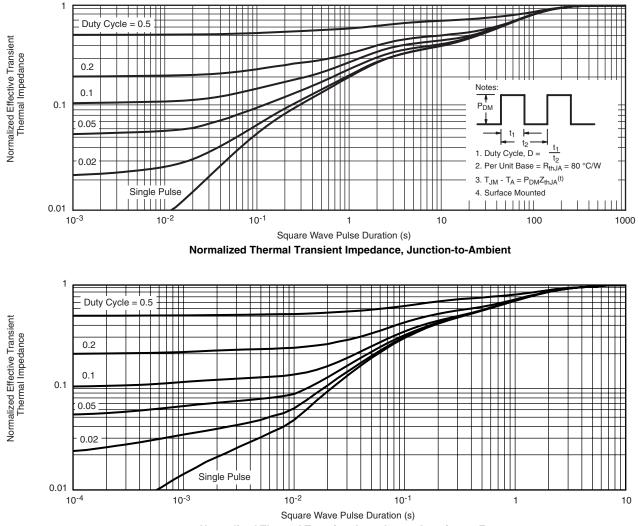






* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Foot



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